

On Parameter Identification for the GISSMO Damage Model

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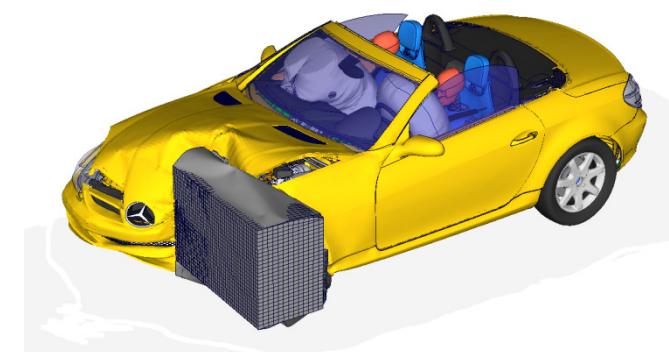
October 9th-10th 2012

Goal

Identification of material parameters for metals, based on experimental data.



- Representation of:
- Plasticity
 - Damage
 - Failure



Focus on the application in crash simulations (and metal forming)

Overview

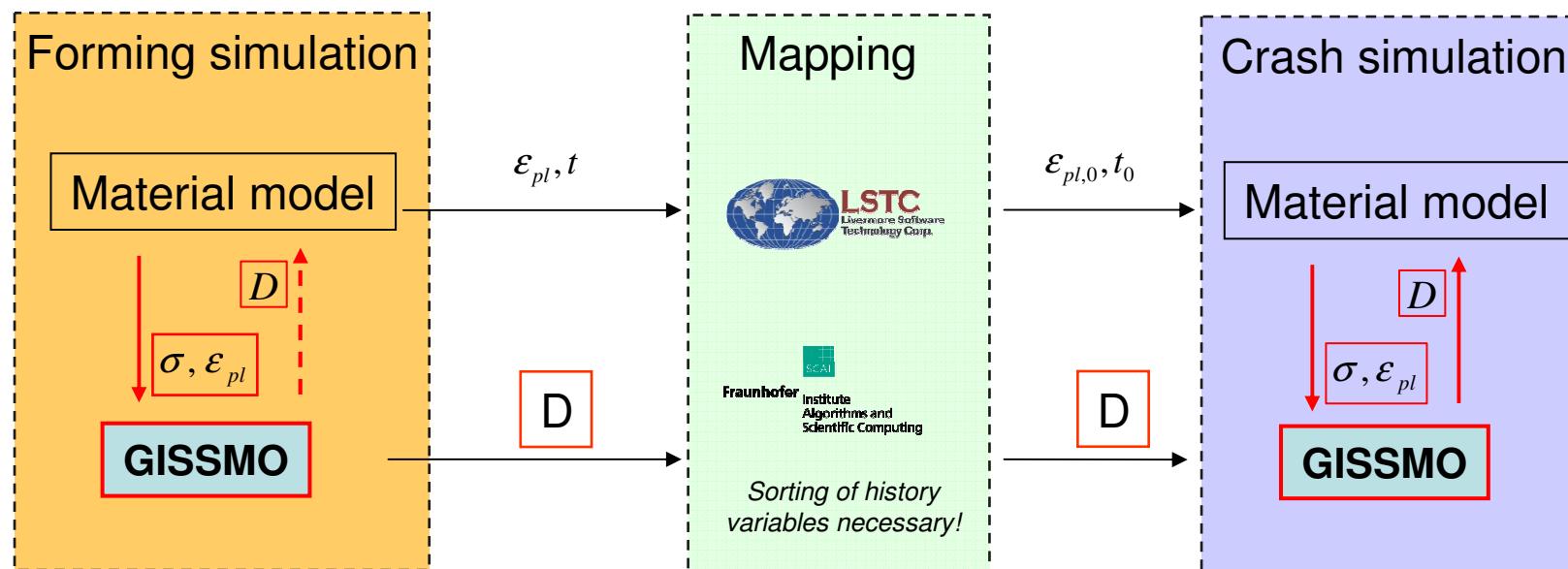
- A generalized scalar damage model (GISSMO)
- Setup and analysis of material tests
- Calibration of a complete material card
 - Yield curve
 - Damage and failure
 - Regularization
- Example: Component tests
- Summary

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A generalized scalar damage model (GISSMO)

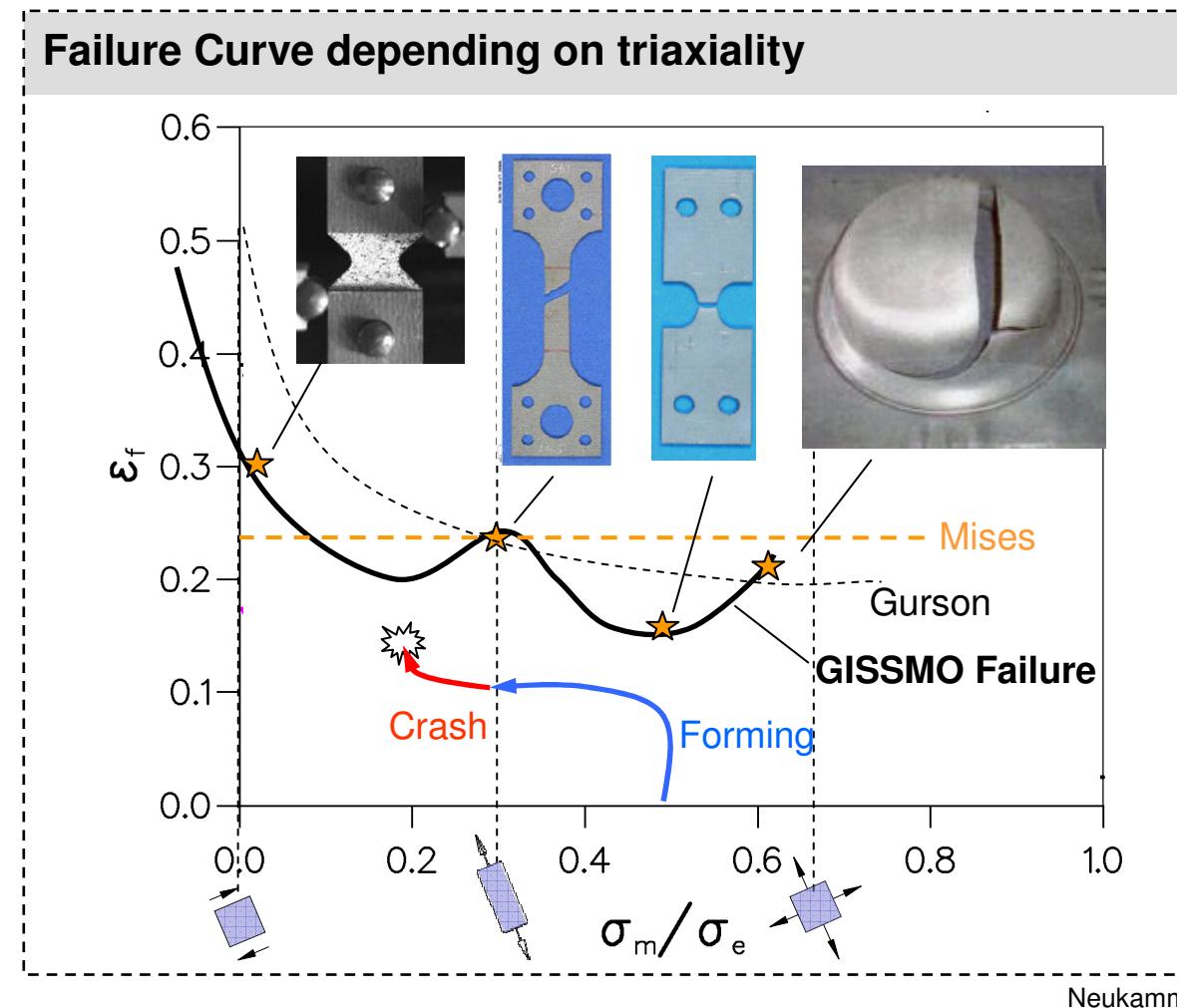
- **GISSMO** = Generalized Incremental Stress State dependent damage MOdel
- Separate treatment of plasticity formulation and damage/failure prediction
- To be combined with arbitrary constitutive models, e.g. *MAT_024 (*von Mises*)
- Coupling of damage to stresses
- Failure strain in dependency of triaxiality
triaxiality η : quotient of mean stress and *von Mises*-stress



Neukamm, Feucht & Haufe [2008-2011]

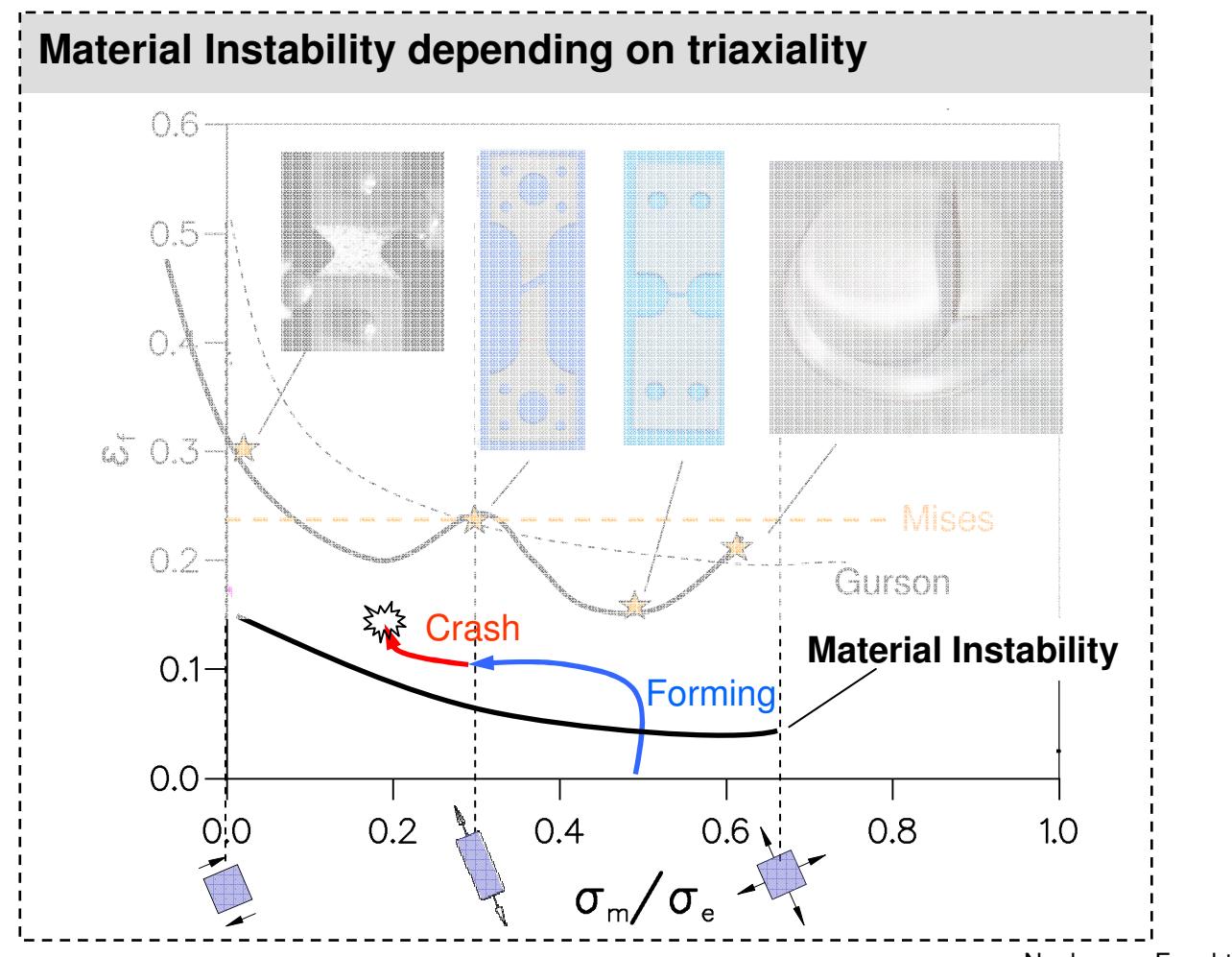
A generalized scalar damage model (GISSMO)

- Damage evolution and failure



A generalized scalar damage model (GISSMO)

- Instability: begin of mesh-size dependency

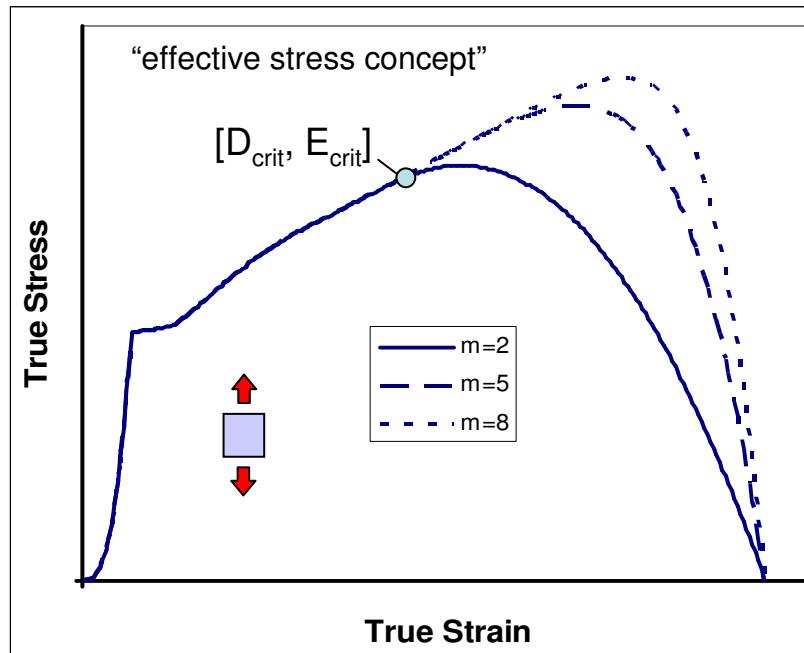


A generalized scalar damage model (GISSMO)

- Coupling of damage to stresses and post-critical behavior

DCRIT, FADEXP: Post-critical behavior

$$\sigma^* = \sigma \left(1 - \left(\frac{D - D_{CRIT}}{1 - D_{CRIT}} \right)^{FADEXP} \right)$$



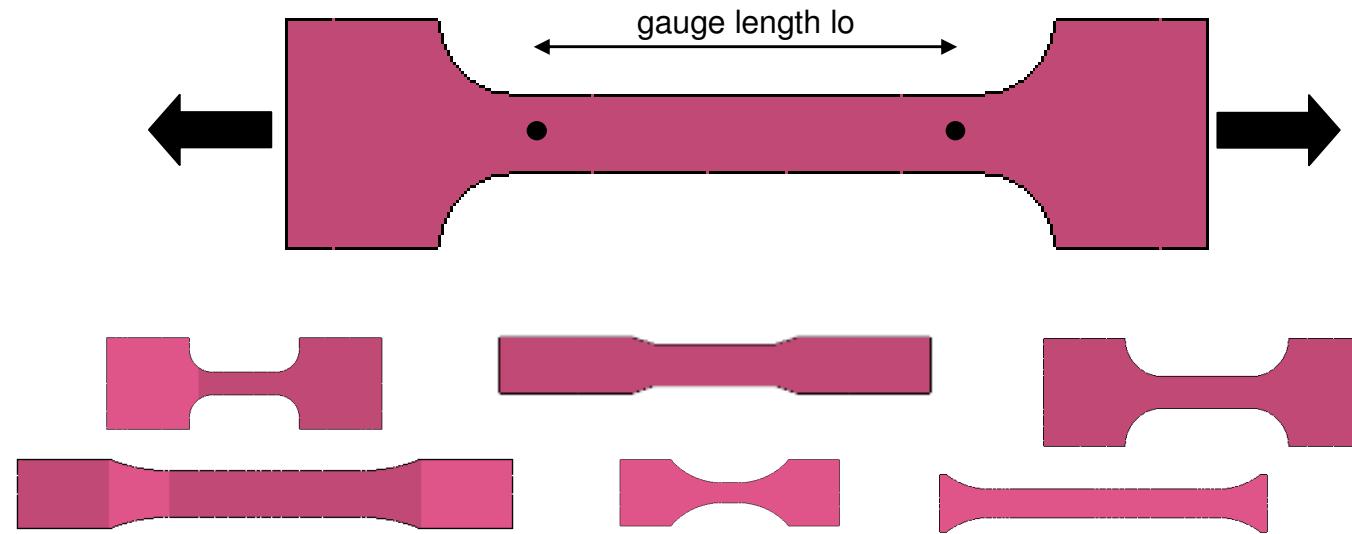
Neukamm, Feucht & Haufe [2008-2011]

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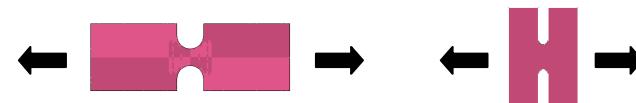
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Setup and analysis of material tests

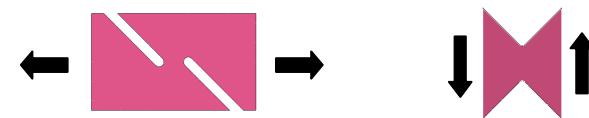
- (Quasi-static) uniaxial tensile tests



- Notched tensile tests



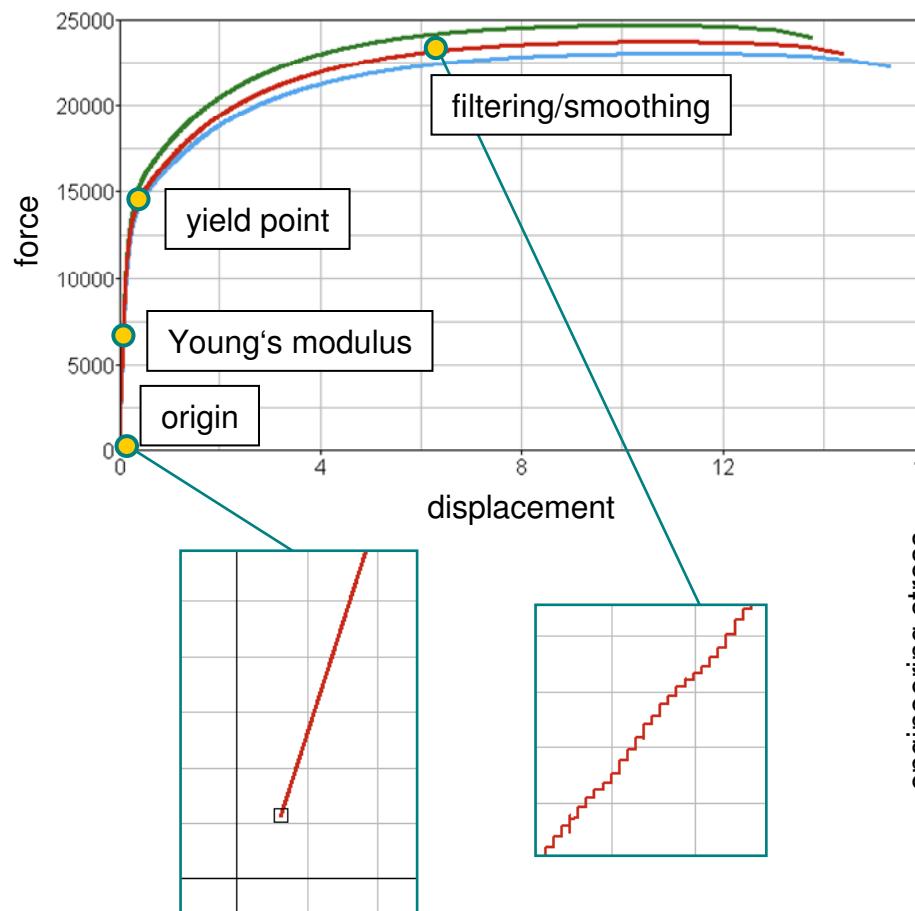
- Shear tests



Setup and analysis of material tests

- Preparation of test curves

Global force vs. displacement curve

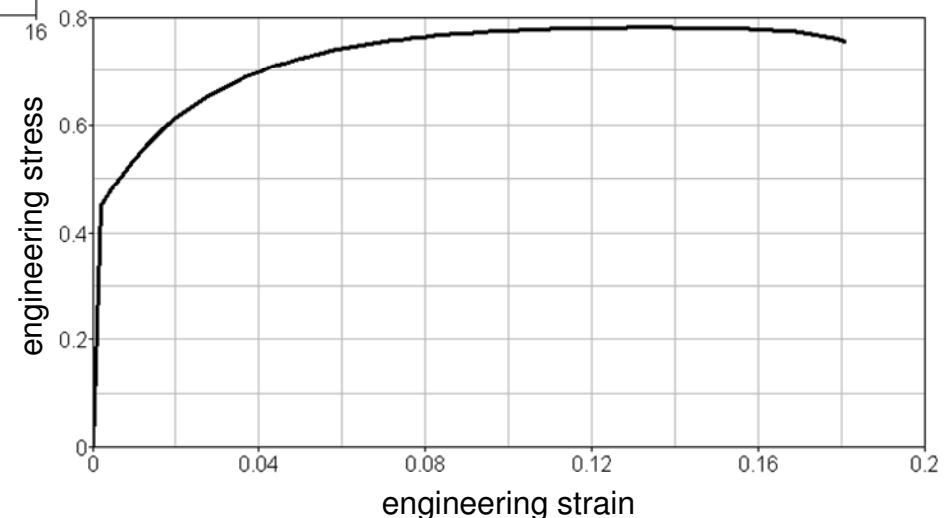


$$\sigma_{eng} = \frac{F}{A_0}$$
$$\epsilon_{eng} = \frac{\Delta l}{l_0}$$



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Engineering stress vs. strain curve

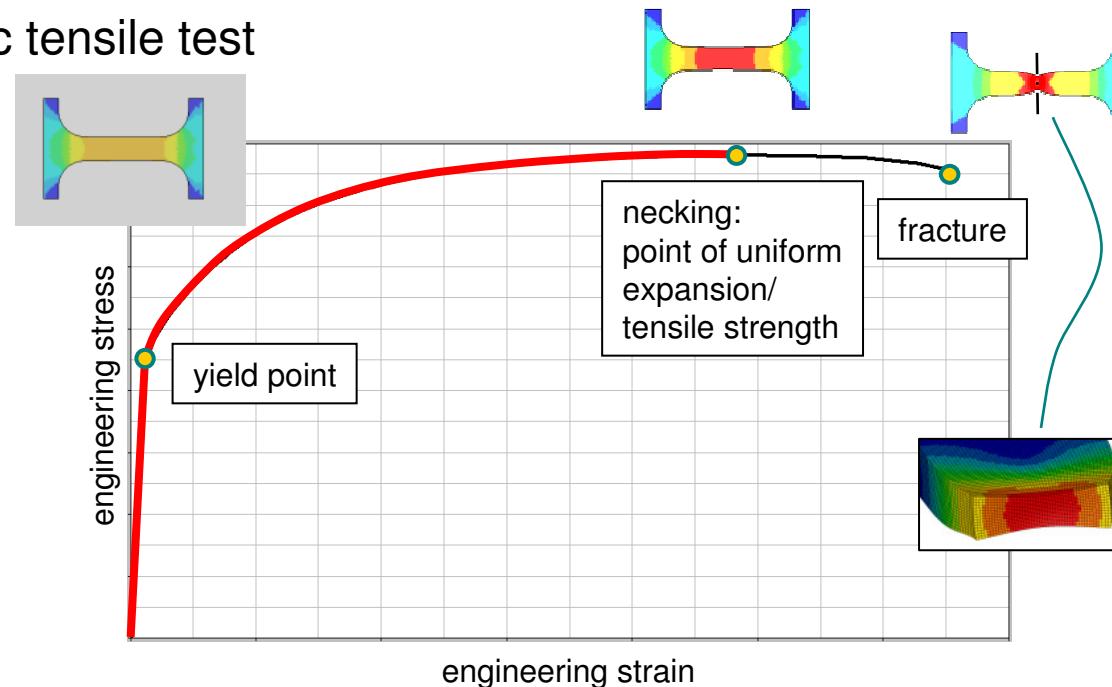


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Calibration of a complete material card: Yield curve

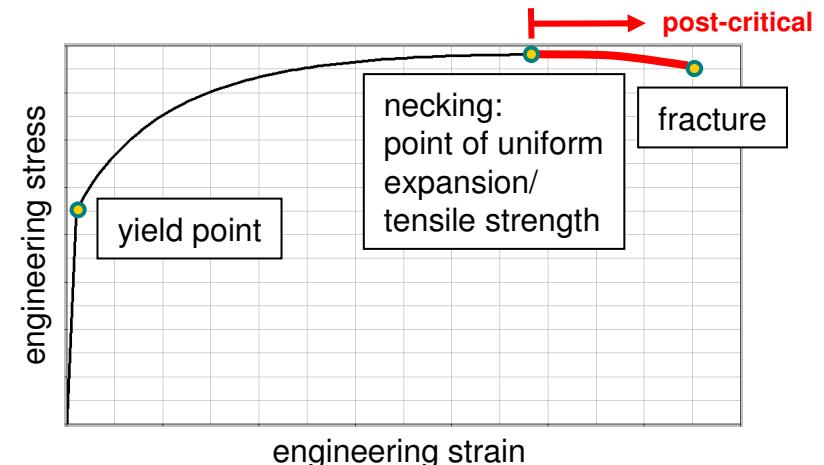
- Plasticity formulation / constitutive model: *von Mises* in *MAT_024
- Yield curve: isotropic hardening curve (eff. stress vs. eff. plastic strain)
- Quasistatic tensile test



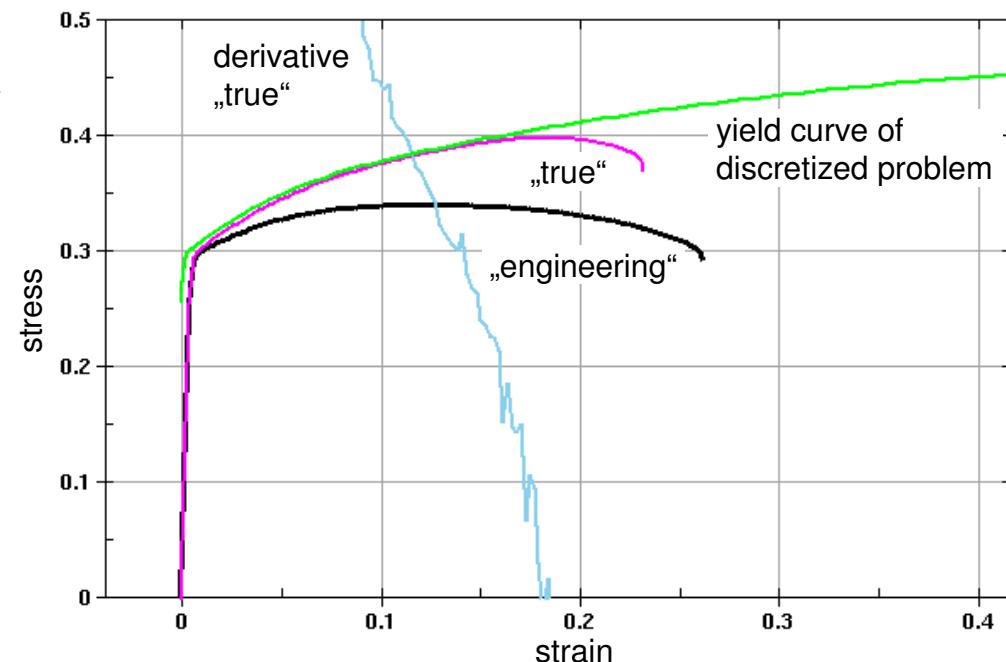
- Up to the point of uniform expansion: direct conversion of test curve
 - Engineering values \rightarrow true (or logarithmic) values \rightarrow compensation of elastic part
 - Stress:
$$\sigma_{true} = \sigma_{eng} (1 + \epsilon_{eng})$$
 - Strain:
$$\epsilon_{true} = \ln(1 + \epsilon_{eng}), \quad \epsilon_{true,plast} = \epsilon_{true} - \frac{\sigma_{true}}{E}$$

Calibration of a complete material card: Yield curve

- Beyond point of uniform expansion:
iterative matching by reverse engineering
 - Individual or analytic approaches
e. g. *Gosh, Hocket-Sherby, Swift, Voce*

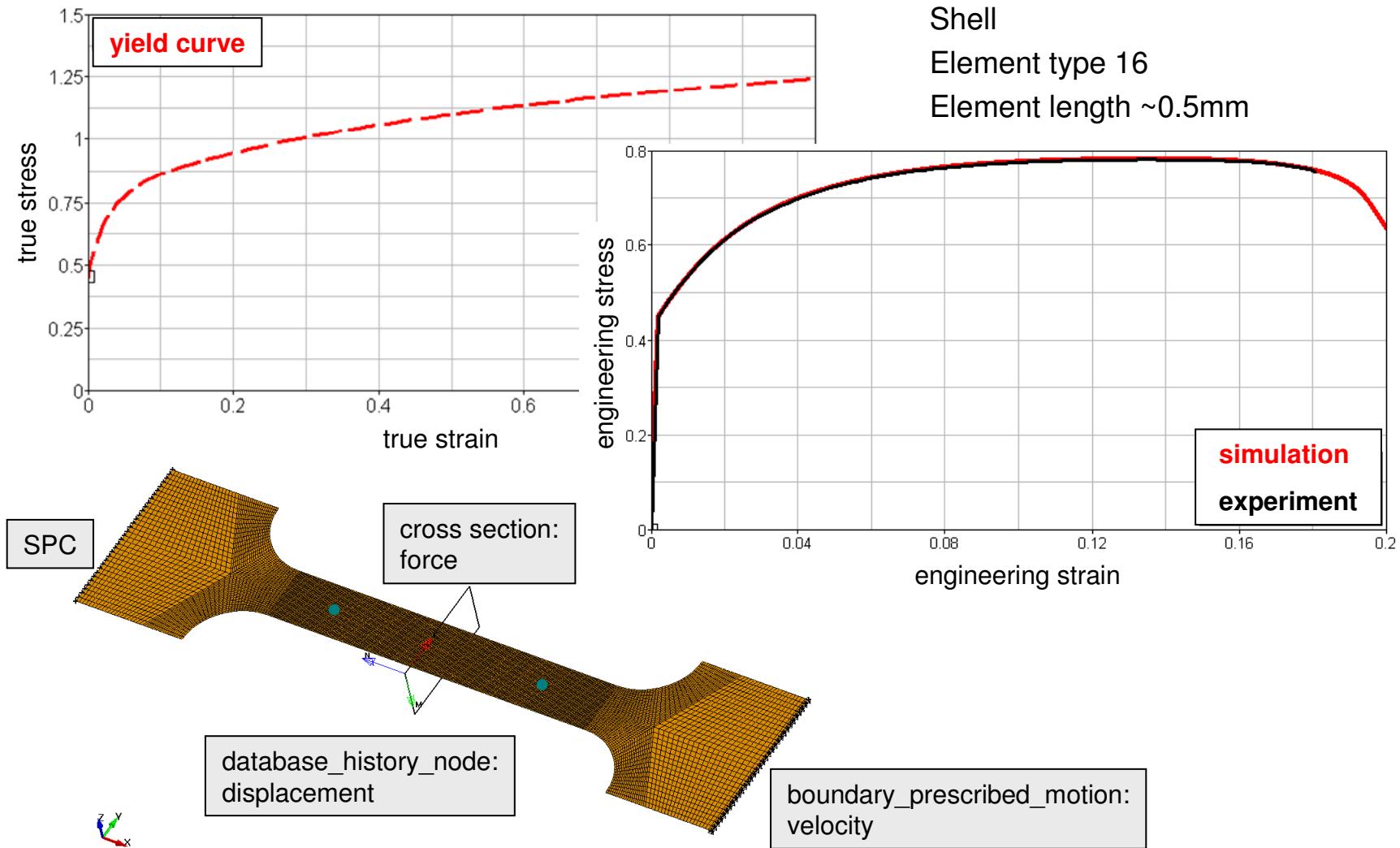


- Optimization using LS-OPT
 - Extrapolation *Hocket-Sherby* with two (out of four) free parameters
 - Variation of yield curve
 - Aim: optimize correlation between engineering stress-strain curves resulting from experiment and simulation



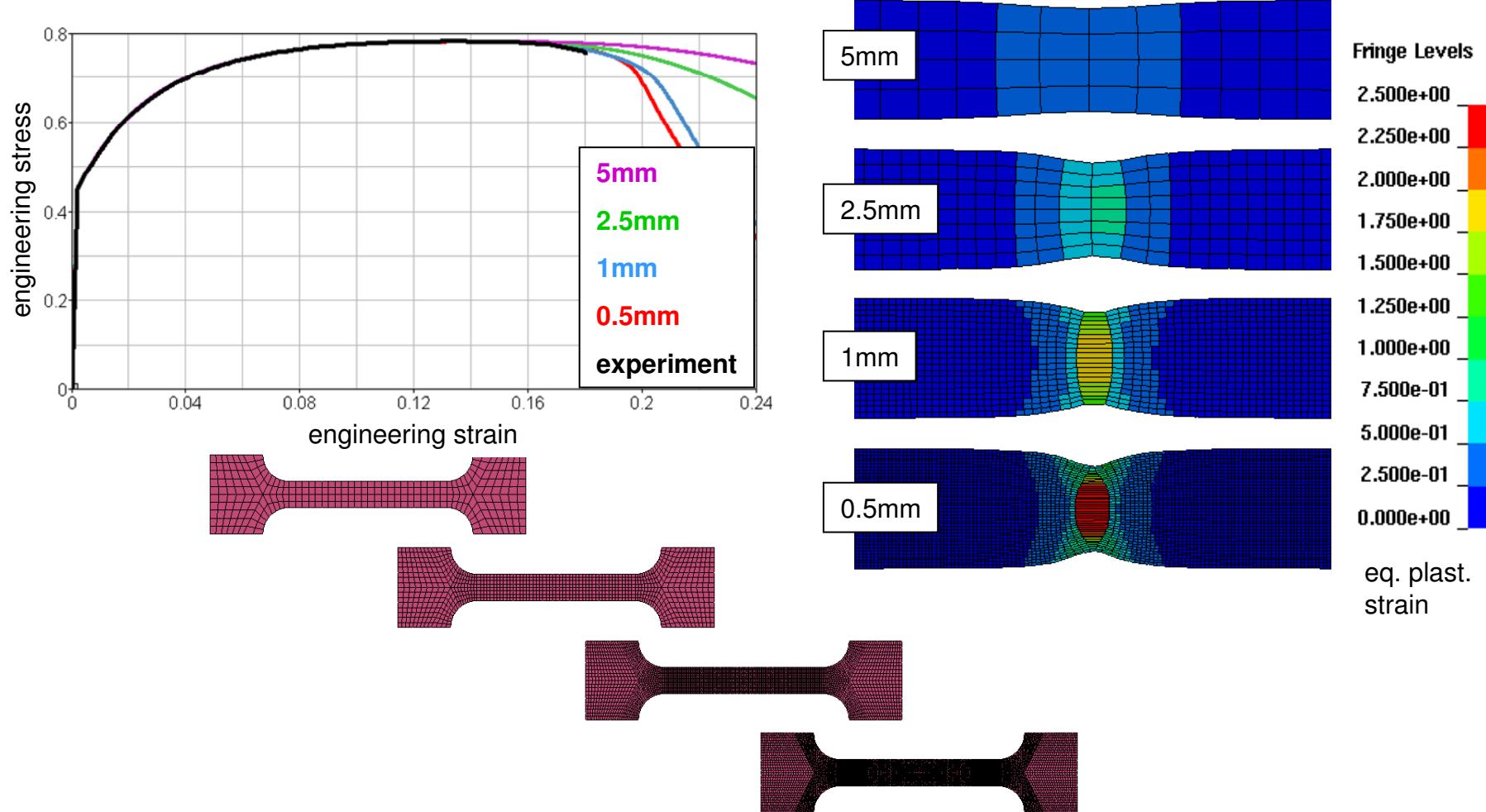
Calibration of a complete material card: Yield curve

- Comparison: experiment and simulation



Calibration of a complete material card: Yield curve

- Element-size dependent behavior in the post-critical range of deformation
→ need for regularization



Calibration of a complete material card: Damage/failure

- Example of a LS-DYNA input for GISSMO

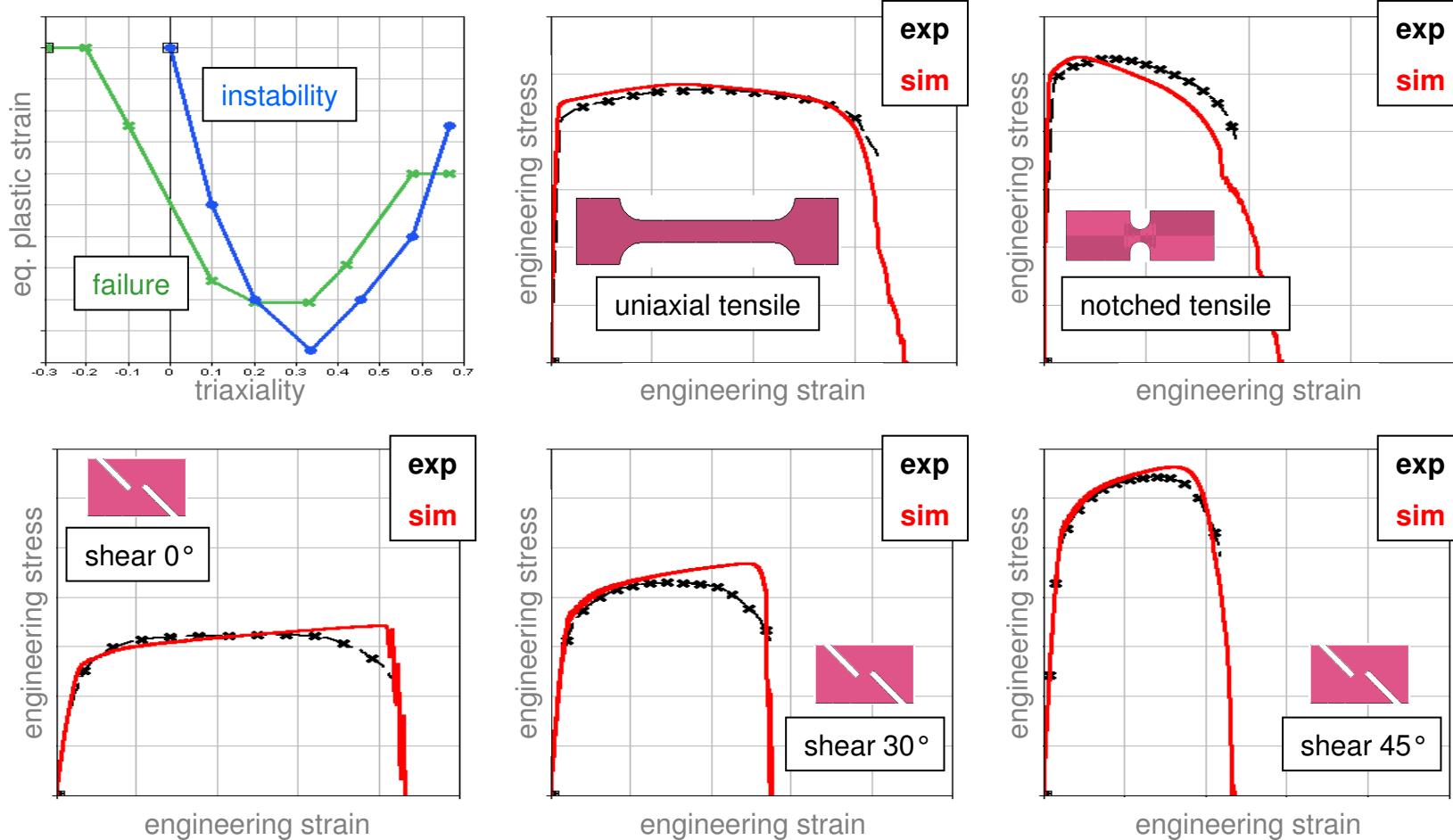
```
*MAT_PIECEWISE_LINEAR_PLASTICITY
$      MID      RO      E      PR      SIGY      ETAN      FAIL      TDEL
$      10
$      C      P      LCSS      LCSR      VP
...
.

*MAT_ADD_EROSION
$      MID      EXCL      MXPRES      MNEPS      EFFEPS      VOLEPS      NUMFIP      NCS
$      10
$      MNPRES      SIGP1      SIGVM      MXEPS      EPSSH      SIGTH      IMPULSE      FAILTM
$      IDAM      DMGTYp      1      LCSDG      100      ECRIT      -200      DCRIT      FADEXP
$      1      14      NAHsv      LCSRS      SHRF      BIAxF      -300      LCREGD      400
$      SIZFLG      REFSZ      14
```

The LS-DYNA input card is annotated with curly braces and red circles to group parameters:

- A brace on the right side groups the first nine parameters under the heading "Standard material input (i.e. *MAT_024)".
- A brace on the right side groups the last four parameters under the heading "Standard failure parameters (optional)".
- A brace on the right side groups the five parameters starting with "DMGTYp" under the heading "GISSMO failure parameters".
- Below the card, six labels are aligned horizontally:
 - Coupling*
 - Failure curve*
 - Damage exponent*
 - Critical damage*
 - Regularization of failure curve*
 - Fadeout exponent (curve definition)*
- Red circles highlight specific parameters: DMGTYp, LCSDG, ECRIT, DMGEXP, DCRIT, and FADEXP.

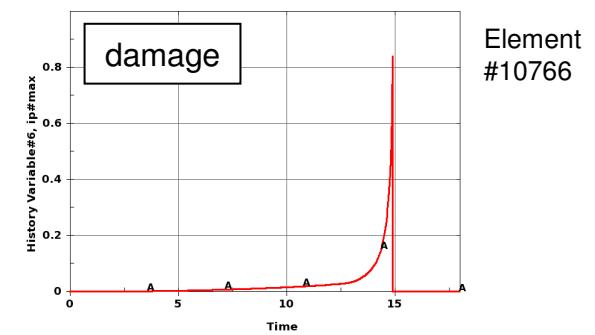
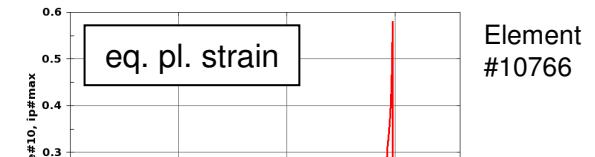
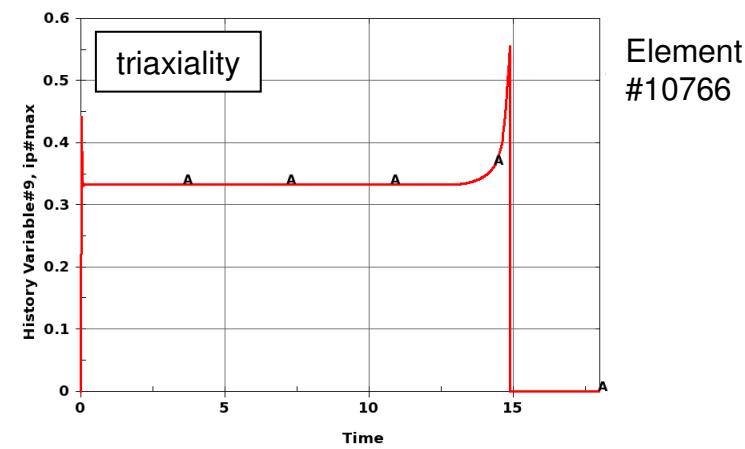
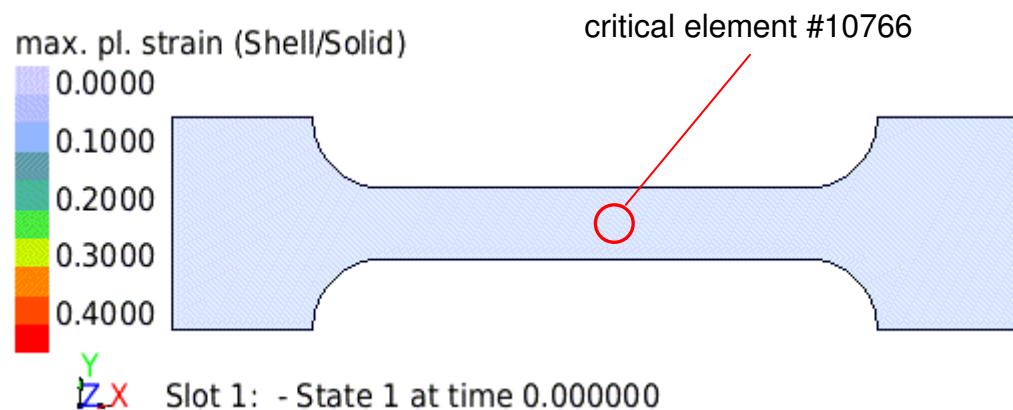
Calibration of a complete material card: Damage/failure



LS-OPT: Identification of fading exponent FADEXP and the two load curves for LCSDG (failure) and ECRIT (instability); mesh size Le~0.5mm

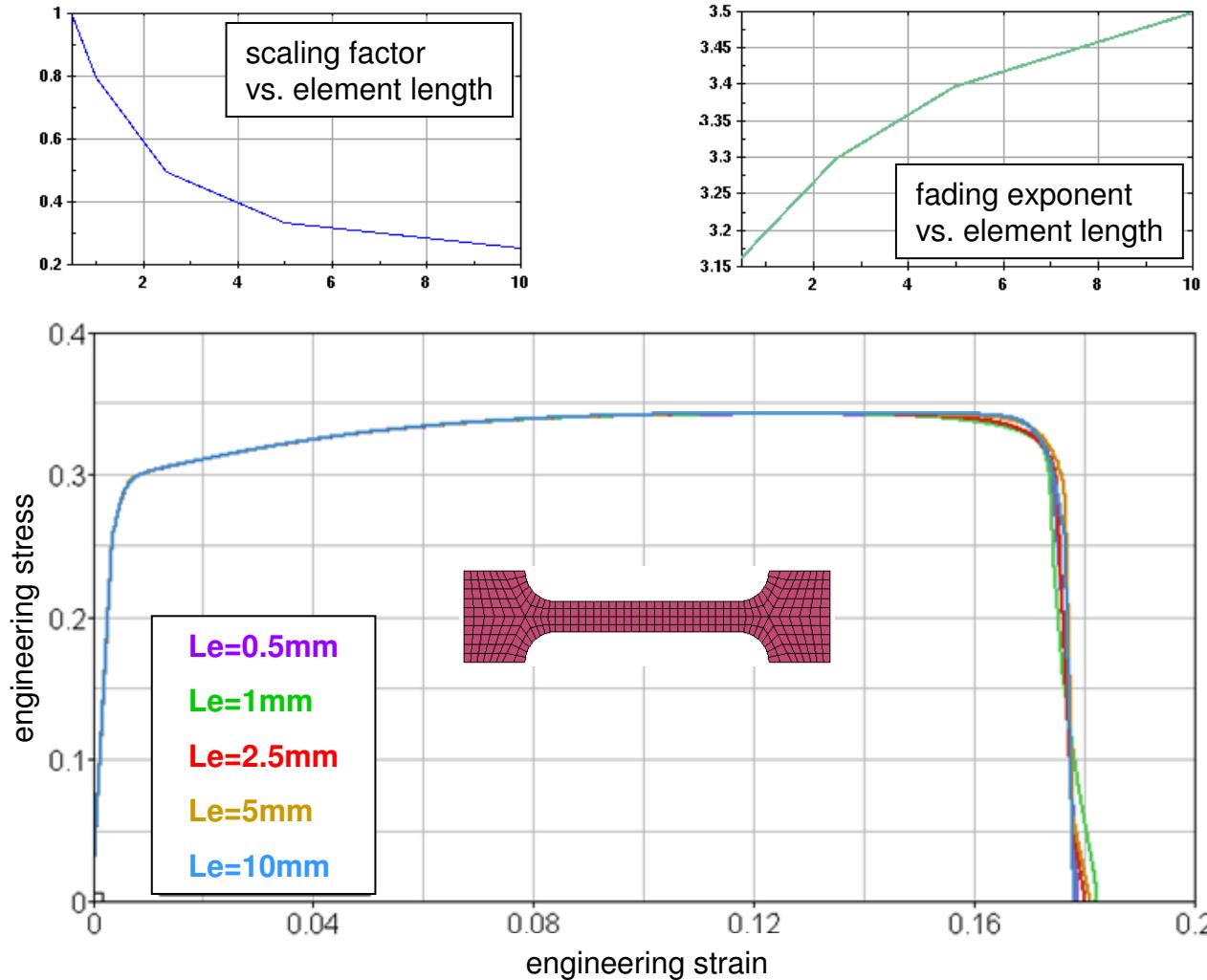
Calibration of a complete material card: Damage/failure

- Some history variables from the simulation of a uniaxial tensile test



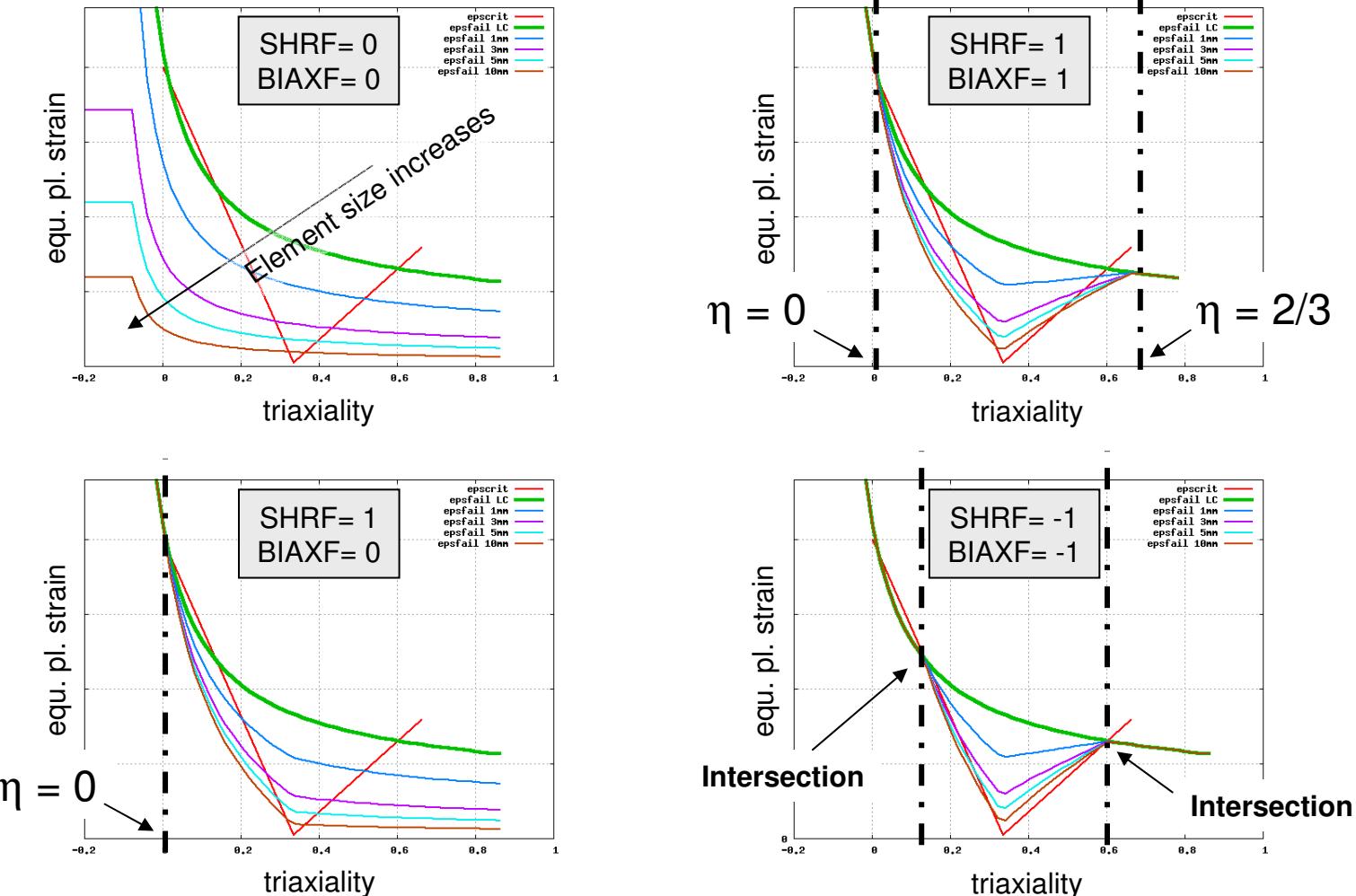
Calibration of a complete material card: Regularization

- Regularization of equivalent plastic strain to failure and fading exponent



Calibration of a complete material card: Regularization

- Regularization under shear and biaxial stress states (LS-DYNA > 971 R5)



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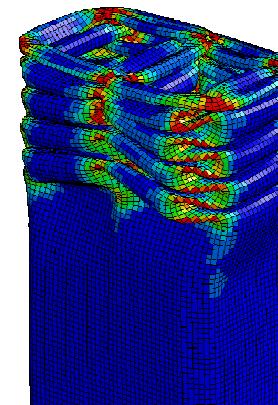
Example: Component tests

- shell elements (ETYP=16)
- SHRF=1 and BIAXF=0

- Drop test / axial crushing of an extruded aluminum profile

→ No regularization under shear-dominated stress states

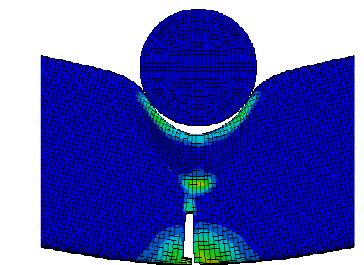
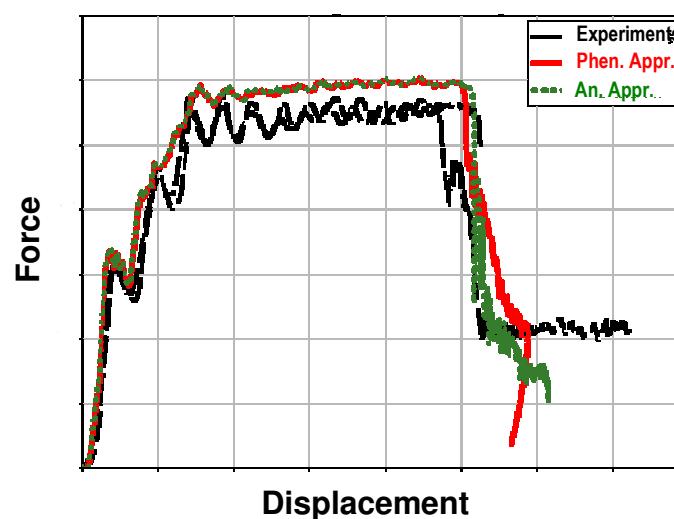
→ Limited failure on the edges



- Three-point bending test

→ Regularization under biaxial stress states

→ Failure occurs



Summary

- GISSMO damage model suitable to capture the physics of damage and failure in a variety of stress states
- User-friendly identification of material parameters using numerical optimization
- Accuracy of failure description depends on the range of stress states covered by specimen tests

New features in GISSMO starting from Release 5:

- Further improvement of the instability treatment
- Enhanced description of failure for solid elements (Lode angle)
- Extended capabilities for stress-state dependent regularization (SHRF&BIAXF)



Thank you!